

Product Specification

XBLW AO4485

P-Channel Enhancement Mode MOSFET











Description

The AO4485 uses advanced trench technology to provide excellent RDS(ON), low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a Battery protection or in other Switching application.

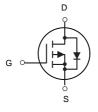
General Features

- ➤ VDS =-40 V ID = -13A
- \triangleright RDS(ON) < 19m Ω @ VGS= 10V

Application

- Battery protection
- Load switch
- Uninterruptible power supply





P-Channel MOSFET

Package Marking and Ordering Information

Product Model	Package Type	Marking	Packing	Packing Qty
XBLW AO4485	SOP-8	AO4485	Tape	3000Pcs/Reel

Absolute Maximum Ratings (Tc=25°C unless otherwise noted)

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	- 40	V
VGS	Gate-Source Voltage	±20	V
I _D @T _A =25°C	Drain Current ³ , V _{GS} @ 10V	-13	А
IDM	Pulsed Drain Current ¹	-52	Α
P _D @T _A =25°C	Total Power Dissipation	3	W
TSTG	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C
Rthj-a	Maximum Thermal Resistance, Junction-ambient ³	41	°C/W



Electrical Characteristics (TJ = 25°C, unless otherwise noted)

Parameter		Symbol	Test Conditions	Min.	Тур.	Max.	Unit
Static Characteristics				<u> </u>			
Drain-Source Breakdown Volta	age	V _{(BR)DSS}	$V_{GS} = 0V, I_D = -250\mu A$	-40	-	-	V
Gate-body Leakage current		Igss	V _{DS} = 0V, V _{GS} = ±20V	-	-	±100	nA
Zero Gate Voltage Drain	TJ=25°C		101/1/	-	-	-1	
Current	T _J =100°C	IDSS	$V_{DS} = -40V, V_{GS} = 0V$	-	-	-100	μA
Gate-Threshold Voltage	1	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	-1.0	-1.5	-2.2	V
- · · · · · · · · · · · · · · · · · · ·		_	V _{GS} = -10V, I _D = -10A	-	14.0	19	
Drain-Source On-Resistance ⁴		R _{DS(on)}	V _{GS} = -4.5V, I _D = -5 A	-	19.5	25	mΩ
Forward Transconductance ⁴		g fs	V _{DS} = -10V, I _D = -10A		44	-	S
Dynamic Characteristics5	i						
Input Capacitance	put Capacitance			-	2525	-	pF
Output Capacitance		Coss	V _{DS} = -20V, V _{GS} =0V, f =1MHz	-	190	-	
Reverse Transfer Capacitance	everse Transfer Capacitance			-	172	-	
Gate Resistance		Rg	f=1MHz	-	10	-	Ω
Switching Characteristics	5	•			•	•	
Total Gate Charge	otal Gate Charge			-	35	_	nC
Gate-Source Charge		Qgs	$V_{GS} = -10V, V_{DS} = -20V,$ $I_{D} = -10A$	-	5.5	-	
Gate-Drain Charge		Q _{gd}		-	8	-	
Turn-On Delay Time		t _{d(on)}		-	14.5	-	ns
Rise Time		tr	$V_{GS} = -10V, V_{DD} = -20V,$	-	20.2	_	
Turn-Off Delay Time		t _{d(off)}	$R_G = 3\Omega$, $I_D = -10A$	-	32	_	
Fall Time		tf		-	10	_	
Drain-Source Body Diode	Character	istics	1	I	1	1	
Diode Forward Voltage ⁴		V _{SD}	Is = -10A, V _{GS} = 0V	-	_	-1.2	V
Continuous Source Current	T _C =25°C	Is	-	-	-	-13	Α

Note:

- 1. Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}$ =150°C.
- 2. The EAS data shows Max. rating . The test condition is V_{DD} = -25V, V_{GS} = -10V, L= 0.1mH, I_{AS} = -34A.
- 3. The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper, The value in any given application depends on the user's specific board design.
- 4. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.
- $5. \ This \ value \ is \ guaranteed \ by \ design \ hence \ it \ is \ not \ included \ in \ the \ production \ test.$



Typical Characteristics

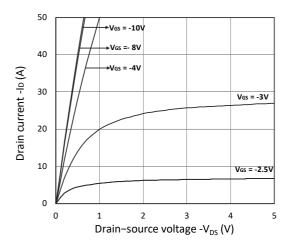


Figure 1. Output Characteristics

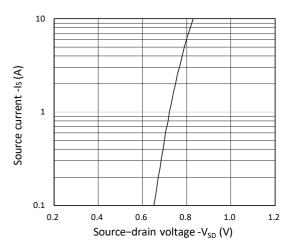


Figure 3. Forward Characteristics of Reverse

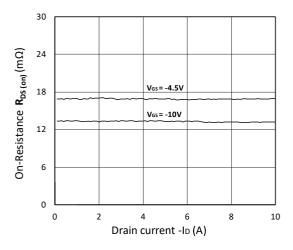


Figure 5. $R_{DS(ON)}$ vs. I_D

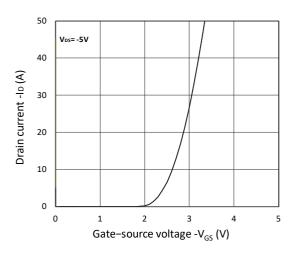


Figure 2. Transfer Characteristics

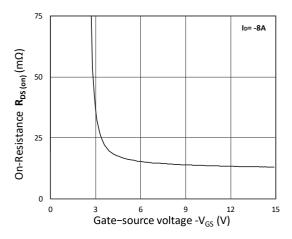


Figure 4. $R_{DS(ON)}$ vs. V_{GS}

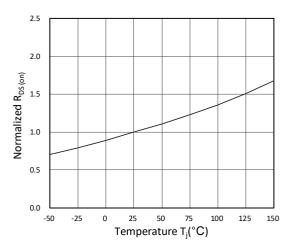


Figure 6. Normalized $R_{DS(on)}$ vs. Temperature

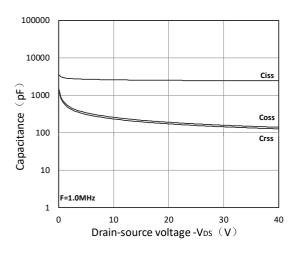


Figure 7. Capacitance Characteristics

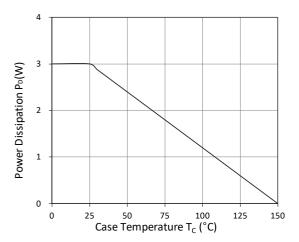


Figure 9. Power Dissipation

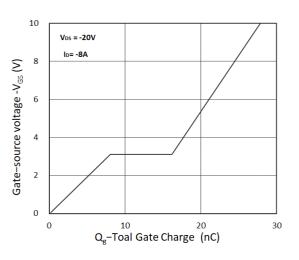


Figure 8. Gate Charge Characteristics

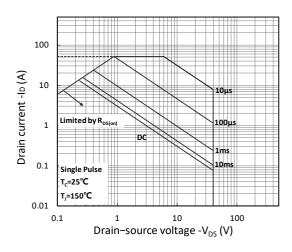


Figure 10. Safe Operating Area

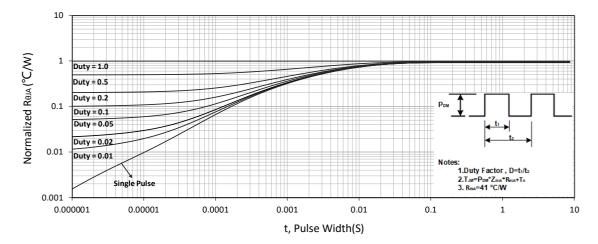


Figure 11. Normalized Maximum Transient Thermal Impedance



Test Circuit

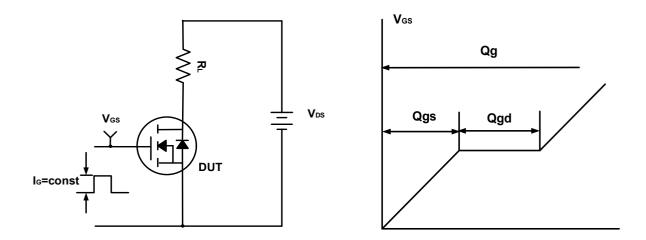


Figure A. Gate Charge Test Circuit & Waveforms

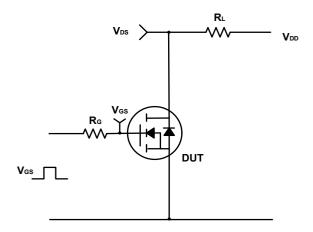


Figure B. Switching Test Circuit & Waveforms

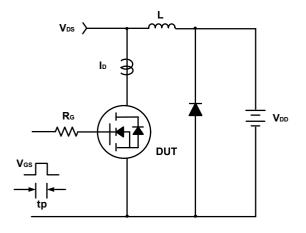
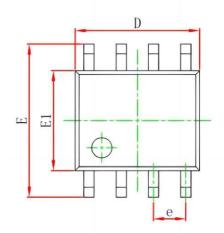


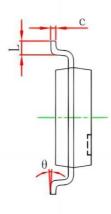
Figure C. Unclamped Inductive Switching Circuit & Waveforms

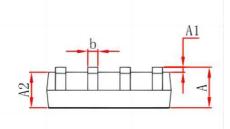


Package Outline Dimensions

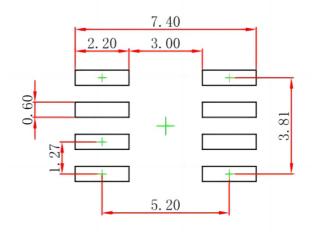
SOP-8







Symbol	Dimensions I	n Millimeters	Dimensions In Inches		
	Min	Max	Min	Max	
A	1.350	1.750	0.053	0.069	
A1	0.100	0.250	0.004	0.010	
A2	1.350	1.550	0.053	0.061	
b	0.330	0.510	0.013	0.020	
С	0.170	0. 250	0.007	0.010	
D	4.800	5.000	0.189	0. 197	
e	1.270 (BSC)		0.050 (BSC)		
E	5.800	6. 200	0. 228	0. 244	
E1	3.800	4.000	0.150	0. 157	
L	0.400	1. 270	0. 016	0.050	
θ	0 °	8°	0 °	8°	



Note:

- 1.Controlling dimension:In millimeters.
- 2.General tolerance:± 0.05mm.
- 3. The pad layout is for reference purposes only.



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BXP2N65D BXT1150N10J BXT1700P06M TSM60NB380CP ROG RQ7L055BGTCR DMNH15H110SK3-13